Laboratoire d'Informatique de Robotique et de Microélectronique de Montpellier



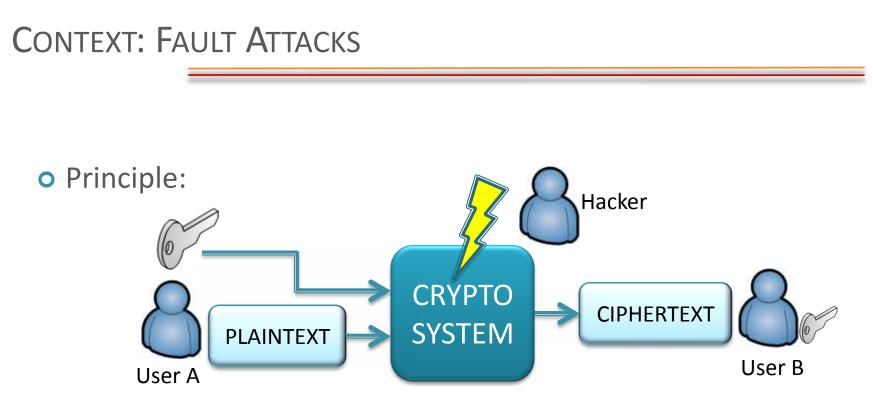
# Local and Direct EM Injection of Power into CMOS Integrated Circuits.

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## OUTLINE

- 1/ Introduction
  - Context of secure IC.
  - EM waves properties.
- o 2/ EM injection Platform
  - Power Injection chain.
  - Illumination model.
- 3/ Experimental results
  - Injections on packaged IC.
  - Injections on unpackaged IC.
- 4/ Conclusion



Disturbing the crypto-computation to extract secret information.

### • Characteristics:

- Very efficient on unprotected systems.
- Unpredictable behavior.
- Complex to protect.

# CONTEXT : ATTACKS VS COUNTERMEASURES

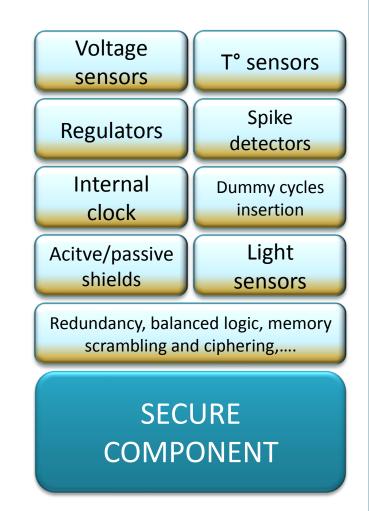
# o Global attacks:

- Operating limits(V, F, T°).
- Voltage spike.
- Clock glitch.

# • Local attacks:

• Laser shoot.

# **oEM attack ?**



# CONTEXT : ELECTROMAGNETIC (EM) WAVES

# **oEM potentials:**

- Penetration capabilities.
- Difficult to detect in electronic environment.
- Low-cost equipment.

# **oFeasibility of EM attacks?**

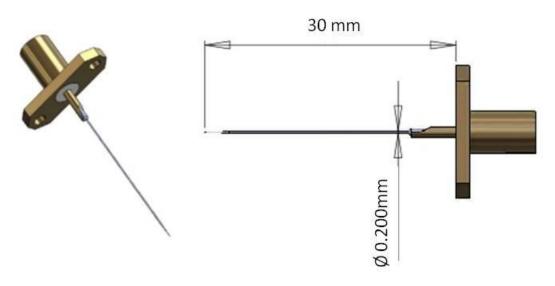
- *Is it possible to create a local coupling with an IC?*
- Is it possible to disturb an IC without removing the package?

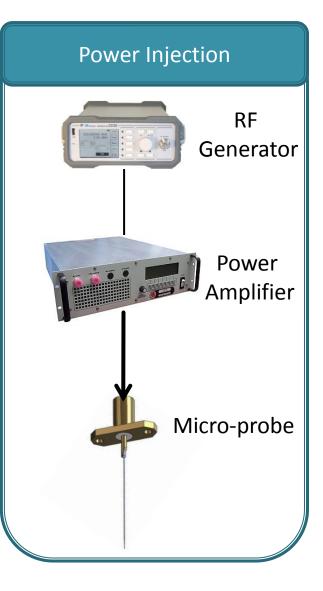
## **EM HARMONIC INJECTION**

# POWER INJECTION CHAIN

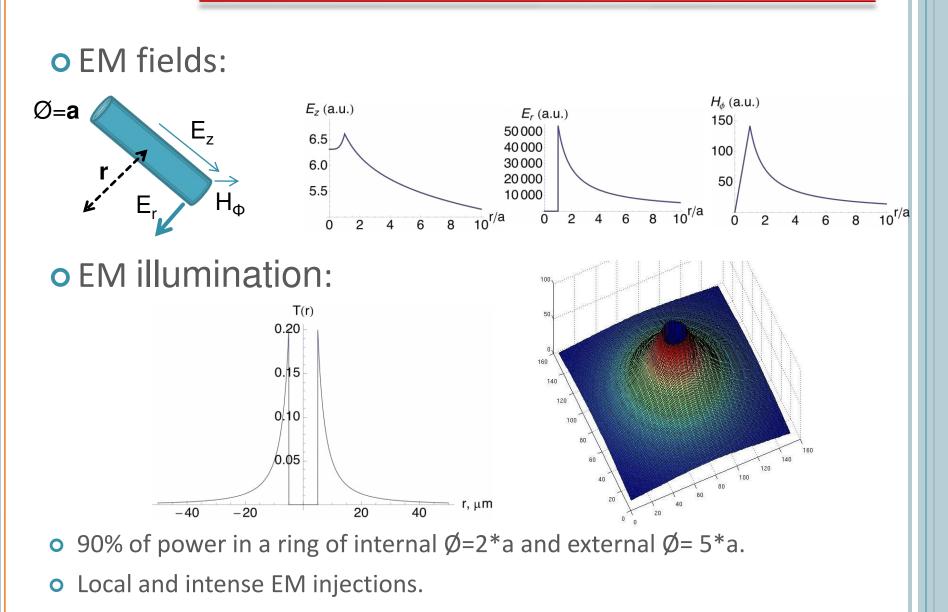
# • List of elements:

- RF generator.
- 50W power amplifier.
- RF cables.
- Micro-probe.



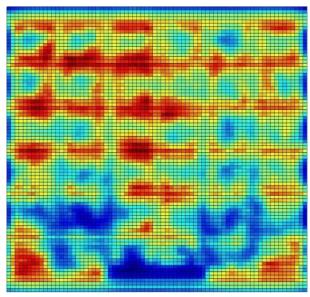


# EM ILLUMINATION MODEL



Our first works demonstrate the possibility of creating local EM couplings.

- The coupling depends on:
  - Probe position and geometry.
  - IC and receptive geometry pattern.
  - Frequency and power.



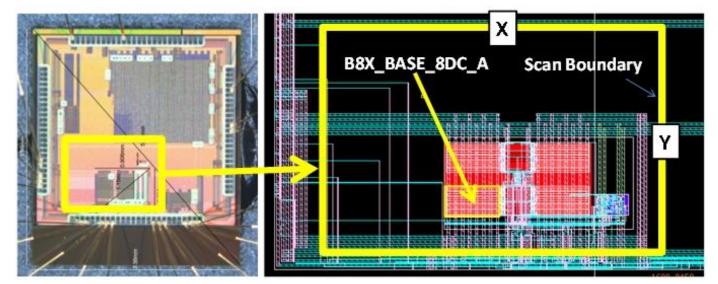
• *"Local ElectroMagnetic Coupling with CMOS Integrated Circuits",* F. Poucheret, B. Robisson, L. Chusseau, P. Maurine, EMC-Compo 2011, Dubrovnik, Croatia.

### EXPERIMENTAL RESULTS

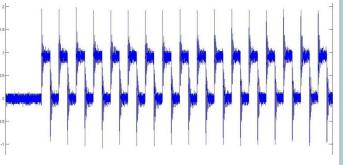
## DUT: RING OSCILLATOR

### • Choice of a Ring Oscillator:

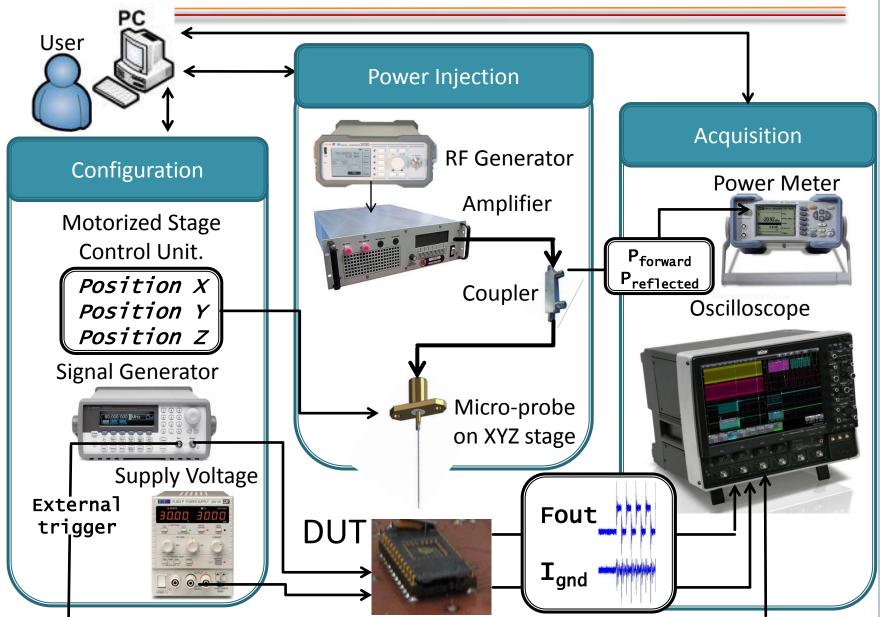
- CMOS technology characterization.
- True Random Number Generator, Internal Clock Generator.



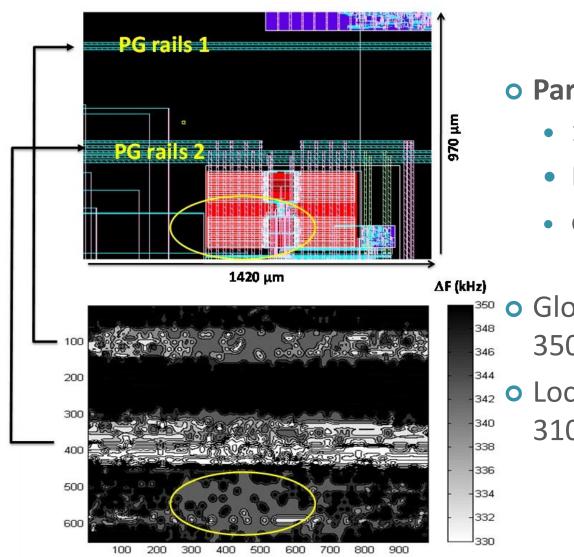
o 101 inverters + counter.
o Output frequency (Fout)=3.81MHz.



## EXPERIMENTAL CONFIGURATION



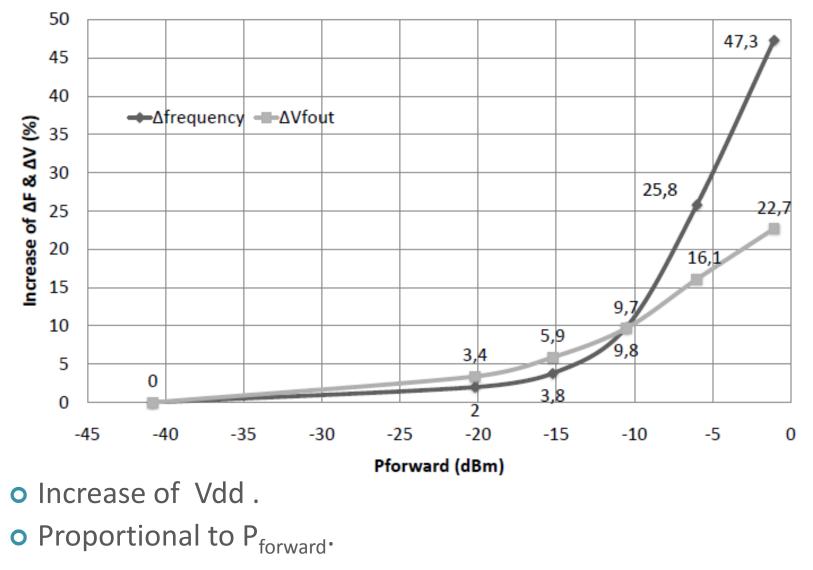
## $\Delta F$ Cartography on unpackaged IC



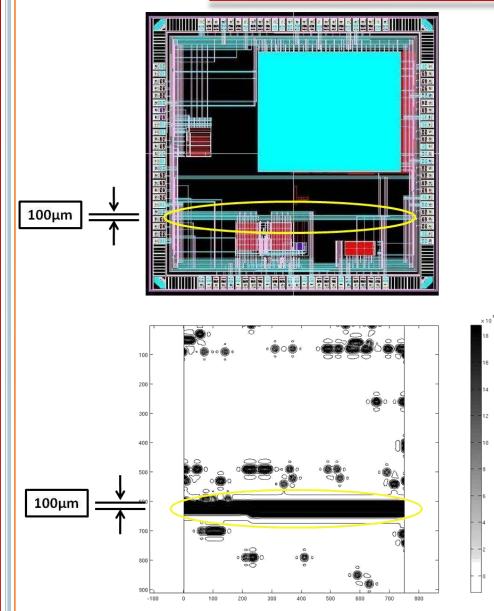
#### • Parameters:

- 1GHz sine.
- P<sub>forward</sub> = 0.1mW.
- Gap probe/IC =  $50\mu m$ .
- Global increase of frequency:
   350kHz (9.2%).
- Local variations between
   310-380kHz.

# $\Delta F$ and $\Delta V$ swing evolutions (Packaged IC).



## $\Delta F$ Cartography on packaged IC



#### • Parameters:

- 1GHz sine.
- $P_{\text{forward}} = 6.63 \text{mW}.$
- Gap probe/IC = 2mm.

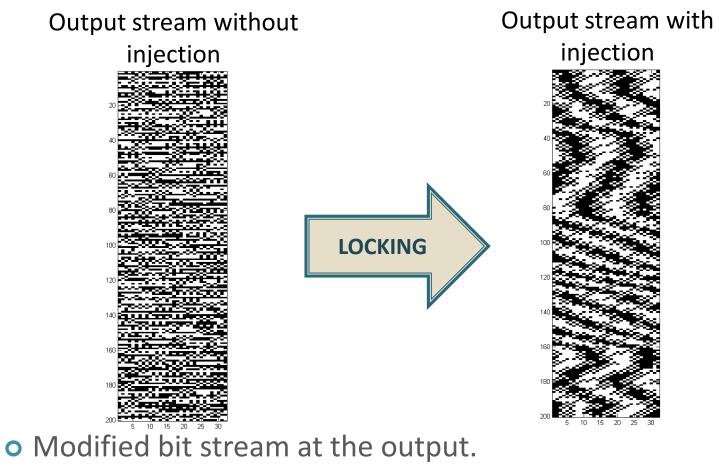
- Local increase of 1.8 MHz (46,6%).
- Detection of patterns (width≈100µm).

• EM harmonic Injection into CMOS IC at High Frequency.

- Energy supply directly to power ground network.
- Contactless (several mm).
- Detection of 100µm wide patterns.

# UNDERGOING WORK ON "WOLD" TRNG

### • First EM Harmonic Injection into TRNG



• Fail the statistical tests.